## Notice of References Cited Application/Control No. 10/658,456 FUKUZAWA ET AL. Examiner Cynthia Lee Applicatios/Patent Under Reexamination FUKUZAWA ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,580,026	06-2003	Koyanagi et al.	136/263
*	В	US-6,451,485	09-2002	James et al.	429/232
*	С	US-2001/0019798	09-2001	Kajiura et al.	429/215
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-		* "	
	К	US-			
	L	US-			
	М	US-		·	

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N /	JP 11-307124	11-1999	JP	Hiroi	H01M 10/40
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.